

N-Channel Silicon Carbide MOSFET Module

Rev.02 - 24 September 2024

Product data sheet

1. General description

WeEnPACK-B1 module with WeEn 1200V Gen2 SiC MOSFET and PressFit pin type. Intergrated with NTC temperature sensor.



2. Features and benefits

- Half bridge topology
- PressFit pins technology
- Low R_{DSon}
- Low Switching Losses
- Low Q_{g} and $C_{\mbox{\tiny rss}}$
- Low Inductive Design

3. Applications

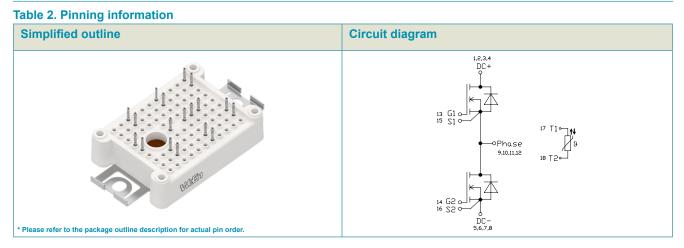
- Power inverters
- AC-DC converters
- DC-DC converters
- Active power factor correctors
- Motor drivers

4. Quick reference data

Parameter	Conditions	Notes	s Values		i	Unit
maximum rating	·					
drain-source voltage	T _j = 25 °C			1200		V
drain current	V _{GS} = 18 V; T _h = 25 °C			45		А
total power dissipation	T _h = 25 °C			105		W
operating junction temperature			-40 to 150		50	°C
Parameter	Conditions	Notes	Min	Тур	Max	Unit
aracteristics						
drain-source on-state	V _{GS} = 15 V; I _D = 40 A; T _j = 25 °C		-	40	-	mΩ
resistance	V _{GS} = 18 V; I _D = 40 A; T _j = 25 °C		-	31.8	45	mΩ
characteristics						
total gate charge	$I_{D} = 40 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	125	-	nC
gate-drain charge	$T_{j} = 25 \text{ °C}$		-	19	-	nC
Irain diode						
recovered charge	I _{SD} = 40 A; V _{GS} = -4 V; di/dt = 8500 A/μs; V _R = 600 V; T _i = 25 °C		-	530	-	nC
	drain-source voltage drain current total power dissipation operating junction temperature Parameter aracteristics drain-source on-state resistance characteristics total gate charge gate-drain charge	drain-source voltage $T_j = 25 \ ^{\circ}C$ drain current $V_{GS} = 18 \ ^{\circ}V; T_h = 25 \ ^{\circ}C$ total power dissipation $T_h = 25 \ ^{\circ}C$ operating junction temperatureParameterConditionsaracteristicsdrain-source on-state resistance $V_{GS} = 15 \ ^{\circ}V; I_D = 40 \ ^{\circ}A; T_j = 25 \ ^{\circ}C$ operating junction temperature $V_{GS} = 18 \ ^{\circ}V; I_D = 40 \ ^{\circ}A; T_j = 25 \ ^{\circ}C$ characteristicstotal gate charge gate-drain charge $I_D = 40 \ ^{\circ}A; \ ^{\circ}V_{DS} = 800 \ ^{\circ}V; \ ^{\circ}GS = -4 \ ^{\circ}V/18 \ ^{\circ}V; \ ^{\circ}T_j = 25 \ ^{\circ}C$ Irain dioderecovered charge $I_{SD} = 40 \ ^{\circ}V_{GS} = -4 \ ^{\circ}V; \ ^{\circ}V$	drain-source voltage $T_j = 25 \ ^{\circ}C$ drain current $V_{GS} = 18 \ V; T_h = 25 \ ^{\circ}C$ total power dissipation $T_h = 25 \ ^{\circ}C$ operating junction temperatureImage: ConditionsParameterConditionsaracteristicsdrain-source on-state resistance $V_{GS} = 15 \ V; \ I_D = 40 \ A; \ T_j = 25 \ ^{\circ}C$ total gate charge $I_D = 40 \ A; \ V_{DS} = 800 \ V; \ V_{GS} = -4 \ V/18 \ V; \ T_j = 25 \ ^{\circ}C$ total gate charge $I_D = 40 \ A; \ V_{DS} = 800 \ V; \ V_{GS} = -4 \ V/18 \ V; \ T_j = 25 \ ^{\circ}C$ total gate charge $I_D = 40 \ A; \ V_{DS} = 800 \ V; \ V_{GS} = -4 \ V/18 \ V; \ T_j = 25 \ ^{\circ}C$ total gate charge $I_D = 40 \ A; \ V_{DS} = 800 \ V; \ V_{GS} = -4 \ V/18 \ V; \ T_j = 25 \ ^{\circ}C$ total gate charge $I_D = 40 \ A; \ V_{GS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ V_{SS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ di/dt = 8$	$\begin{tabular}{ c c c c c } \hline $T_j = 25 \ ^{\circ}C$ & $T_h = 25 \ ^{\circ}C$ & $total power dissipation$ & $T_h = 25 \ ^{\circ}C$ & $total power dissipation$ $T_h = 25 \ ^{\circ}C$ & $total power dissipation$ & $T_h = 25 \ ^{\circ}C$ & $total power dissipation$ & $total$	drain-source voltage $T_j = 25 \ ^{\circ}C$ 1200drain current $V_{GS} = 18 \ V; T_n = 25 \ ^{\circ}C$ 45total power dissipation $T_n = 25 \ ^{\circ}C$ 105operating junction temperature-40 to 15ParameterConditionsNotesMinTyparacteristicsdrain-source on-state resistance $V_{GS} = 15 \ V; \ I_D = 40 \ A; \ T_J = 25 \ ^{\circ}C$ -40operating junction temperature $V_{GS} = 15 \ V; \ I_D = 40 \ A; \ T_J = 25 \ ^{\circ}C$ -40aracteristics $V_{GS} = 18 \ V; \ I_D = 40 \ A; \ T_J = 25 \ ^{\circ}C$ -125operating junction temperature $I_D = 40 \ A; \ V_{DS} = 800 \ V; \ V_{GS} = -4 \ V/18 \ V; \ T_J = 25 \ ^{\circ}C$ -125operating junction resistance $I_D = 40 \ A; \ V_{DS} = 800 \ V; \ V_{GS} = -4 \ V/18 \ V; \ T_J = 25 \ ^{\circ}C$ -125operating junction resistance $I_D = 40 \ A; \ V_{GS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ -19operating diodeI_{SD} = 40 \ A; \ V_{GS} = -4 \ V; \ di/dt = 8500 \ A/\mus; \ -530$	$\begin{tabular}{ c c c c c } \hline drain-source voltage & T_j = 25 \ ^{\circ}C & 1200 \\ \hline drain current & V_{CS} = 18 \ V; \ T_h = 25 \ ^{\circ}C & 45 \\ \hline total power dissipation & T_h = 25 \ ^{\circ}C & 105 \\ \hline operating junction temperature & Conditions & Notes & Min & Typ & Max \\ \hline Parameter & Conditions & Notes & Min & Typ & Max \\ \hline Parameter & Conditions & Notes & Min & Typ & Max \\ \hline aracteristics & & & & & & & & & & & & & & & & & & &$

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5. Pinning information



6. Ordering information

Table 3. Ordering information								
Type number	Package Name	Orderable part number	Packing method	Small packing quantity		Package issue date		
WMSC040H12B1P	WeEnPACK-B1	WMSC040H12B1P6T	Tray	16	WeEnPACK- B1PHB-A	14-Dec-2023		

7. Marking

Table 4. Marking codes							
	Type number	Marking codes					
	WMSC040H12B1P	WMSC040H12B1P					

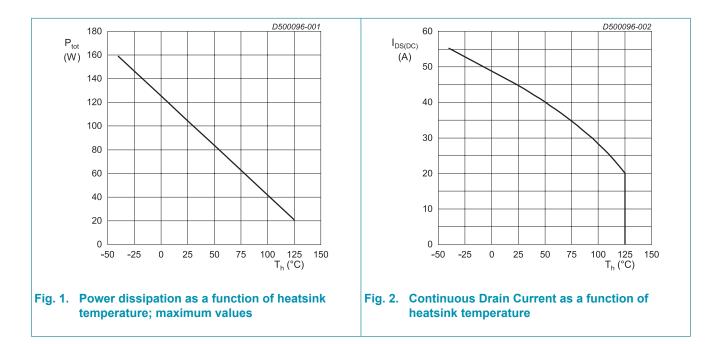
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8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
T _{stg}	storage temperature			-40 to 125	°C
T _{j.op}	operating junction temperature			-40 to 150	°C
T _{j.max}	maximum junction temperature	Intermittent condition with shortened lifetime		-40 to 175	°C
V _{ISOL}	RMS isolation voltage	T _j = 25 °C; all terminals shorted; f = 50 Hz; t = 1 s		3500	V
MOSFET	·	-	·		·
V _{DS}	drain-source voltage	T _j = 25 °C		1200	V
$V_{GS,max}$	gate-source voltage	Absolute maximum values		-12 to 24	V
$V_{GS,op}$	gate-source voltage	Recommended operational values		-4 to 18	V
P _{tot}	total power dissipation	T _h = 25 °C		105	W
I _D	drain current	V _{GS} = 18 V; T _h = 25 °C		45	А
		V _{GS} = 18 V; T _h = 100 °C		28	А
I _{DM}	peak drain current	pulse width t_p limited by T_{jmax}	Fig.17	90	А
E _{as}	single pulse drain-to- source avalanche	I_{AS} = 15 A; L = 1 mH; V _{DD} = 100 V; T _{j(init)} = 25 °C; per MOSFET		112.5	mJ
Body Dioc	de				
I _{SD}	DC body diode forward current	V _{GS} = -4 V; T _h = 25 °C		24	А
I _{SD,pulse}	Pulse body diode current	verified by design, t_p limited by T_{imax}		90	А



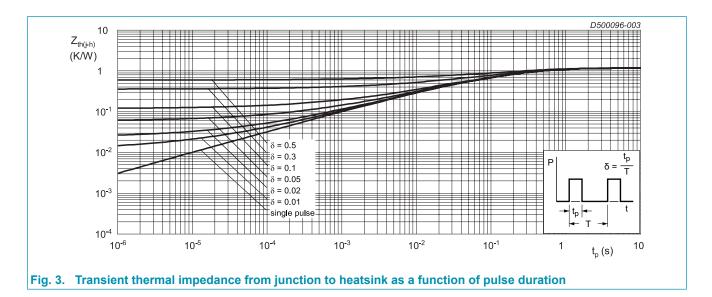
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9. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R _{th(j-c)}	thermal resistance from junction to case	per MOSFET		-	0.51	-	K/W
$R_{th(j-h)}$	thermal resistance from junction to heatsink	per MOSFET, $\lambda_{grease} = 1 \text{ W/(m·K)}$		-	1.20	-	K/W
Internal Is	solation	basic insulation (class 1, IEC 61140)		Al ₂ O ₃			
d_{Creep}	Creepage distance	terminal to heatsink		-	11.5	-	mm
		terminal to terminal		-	6.3	-	mm
d _{Clear}	Clearance	terminal to heatsink		-	10	-	mm
		terminal to terminal		-	5	-	mm
CTI	Comperative tracking index				>200		
F	Mounting force per clamp			20	-	50	N
G	Approximate Weight			-	20	-	g

Table 6. Thermal characteristics

Note: Module is ESD sensitive. Handling precautions are recommended.



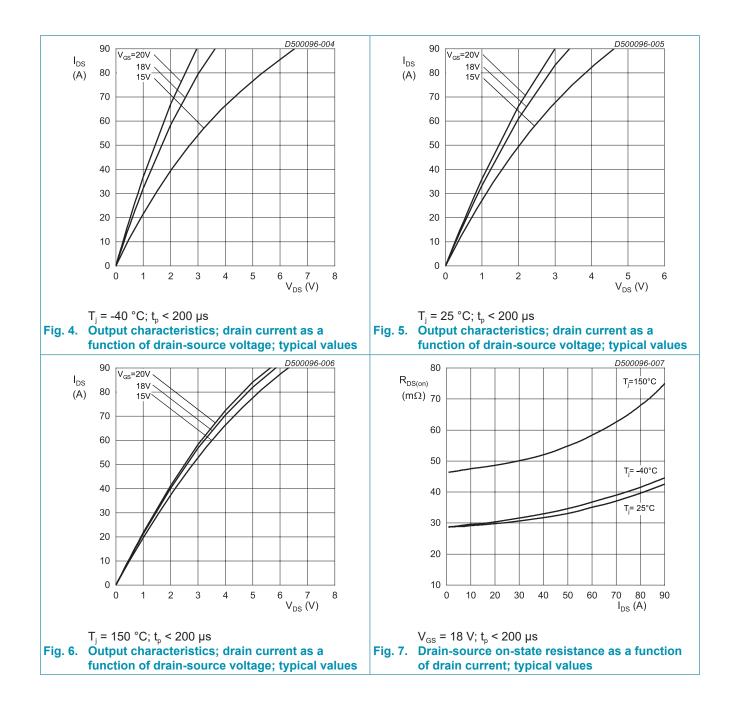
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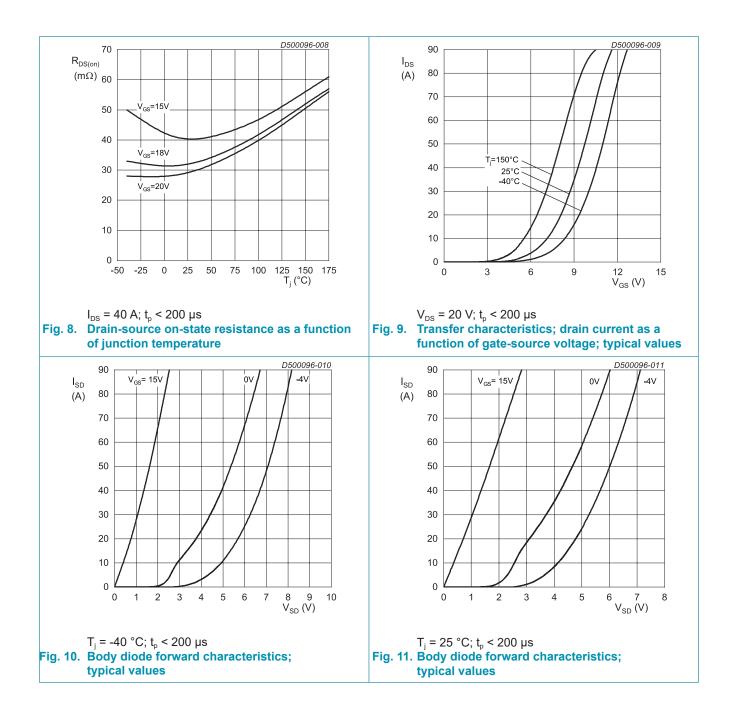
10. Characteristics

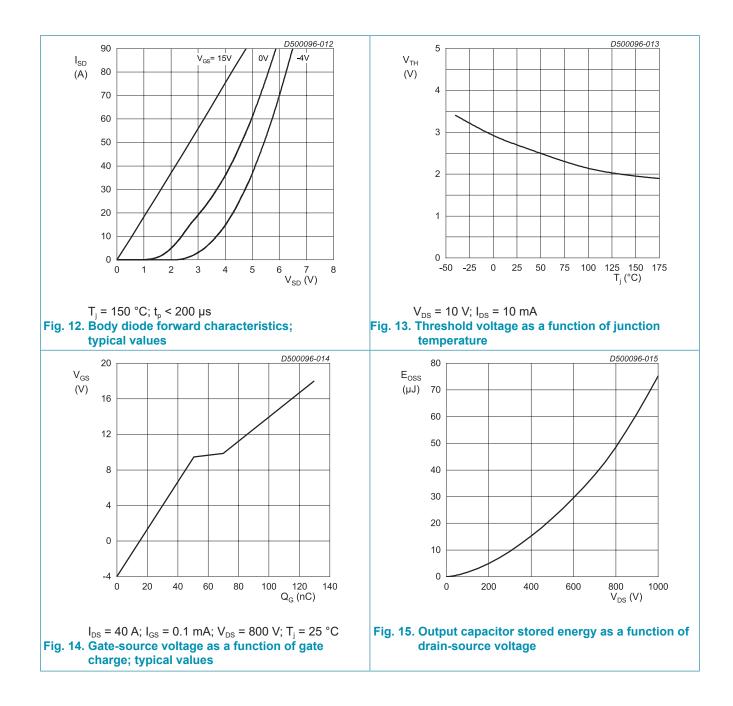
Table 7. Characteristics

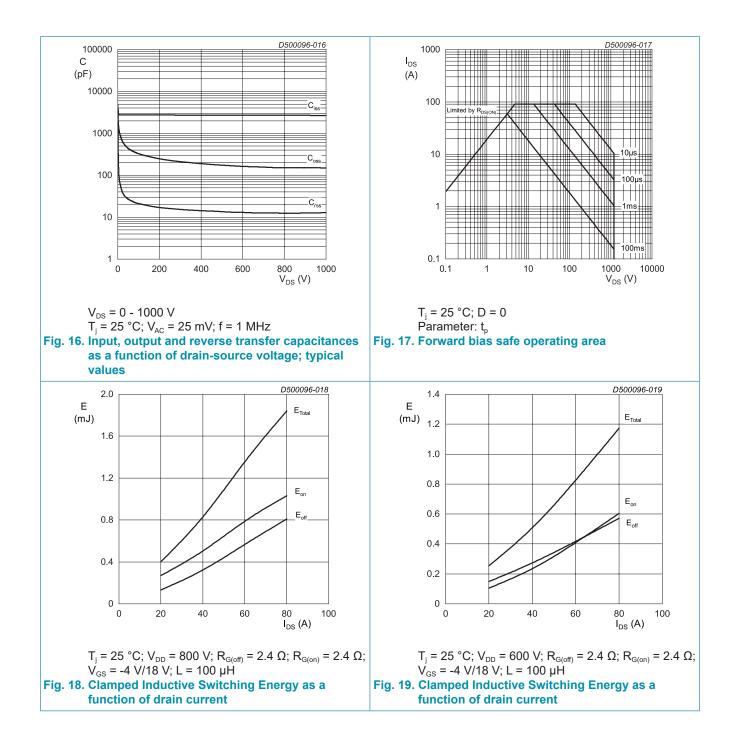
MOSFET							
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	I_{D} = 200 µA; V_{GS} = 0 V; T_{j} = 25 °C		1200	-	-	V
V _{GS(th)}	gate-source threshold	I_{D} = 10 mA; V_{DS} = 10 V; T_{j} = 25 °C		1.9	2.5	3.5	V
	voltage	I_{D} = 10 mA; V_{DS} = 10 V; T_{j} = 25 °C		-	1.9	-	V
I _{DSS}	drain leakage current	V_{DS} = 1200 V; V_{GS} = 0 V; T_j = 25 °C		-	0.4	200	μA
I _{GSS}	gate leakage current	V_{GS} = 24 V; V_{DS} = 0 V; T_j = 25 °C		-	20	200	nA
	(absolute value)	V_{GS} = -12 V; V_{DS} = 0 V; T_j = 25 °C		-	20	200	nA
$R_{\text{DS(on)}}$	drain-source on-state	V _{GS} = 15 V; I _D = 40 A; T _j = 25 °C		-	40	-	mΩ
	resistance	V _{GS} = 18 V; I _D = 40 A; T _j = 25 °C		-	31.8	45	mΩ
		V _{GS} = 18 V; I _D = 40 A; T _j = 125 °C		-	46.6	-	mΩ
		V _{GS} = 18 V; I _D = 40 A; T _j = 150 °C		-	52	-	mΩ
		V _{GS} = 18 V; I _D = 40 A; T _j = 175 °C		-	54.6	-	mΩ
R _G	gate resistance, each side	f = 1 MHz; T _j = 25 °C, each die with 4.7 Ω R _{G(ext)} in series		-	3.7	-	Ω
g _{fs}	transconductance	V _{DS} = 20 V; I _D = 40 A; T _j = 25 °C		-	23	-	S
Dynamic	characteristics						
Q _{G(tot)}	total gate charge	$I_{D} = 40 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	125	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C		-	51	-	nC
Q_{GD}	gate-drain charge			-	19	-	nC
C _{iss}	input capacitance	$V_{DS} = 1000 V; V_{GS} = 0 V; f = 1 MHz;$		-	2.7	-	nF
C _{oss}	output capacitance	T _j = 25 °C		-	150	-	pF
C_{rss}	reverse transfer capacitance			-	12.9	-	pF
E _{oss}	Coss stored energy			-	75	-	μJ
t _{d(on)}	turn-on delay time	$V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	12	-	ns
t,	rise time	$R_{G(ext)} = 2.4 \Omega$; I _D = 40 A; L = 100 μH; T _i = 25 °C		-	8	-	ns
$t_{\rm d(off)}$	turn-off delay time			-	38	-	ns
t _f	fall time			-	17	-	ns
E _{on}	turn-on energy			-	490	-	μJ
E _{off}	turn-off energy			-	310	-	μJ

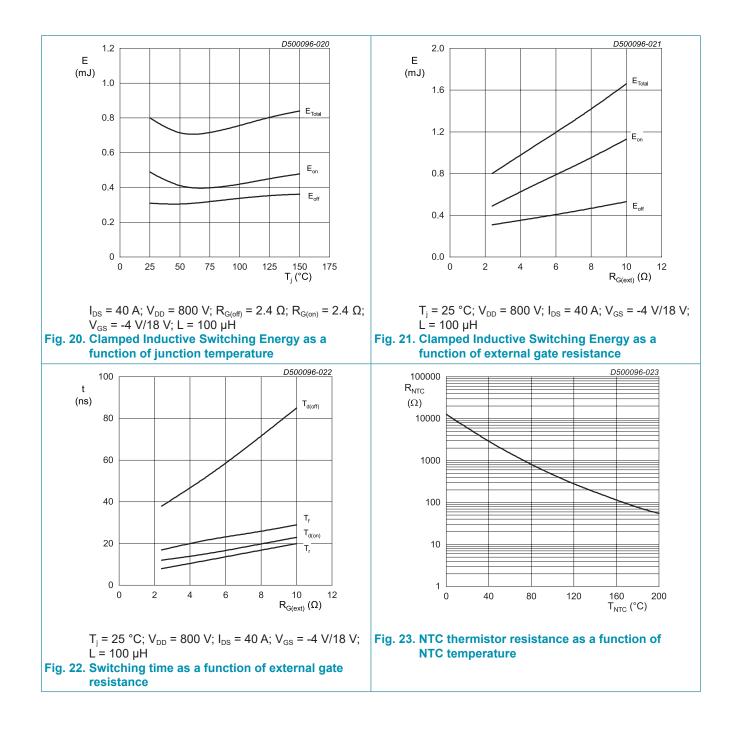
Body did	de						
Symbol	Parameter	Conditions Notes Min Typ Ma		Max	Unit		
Static ch	aracteristics	·					
V _{SD}	source-drain voltage	V_{GS} = -4 V; I_{SD} = 40 A; T_j = 25 °C		-	5.6	-	V
		V _{GS} = -4 V; I _{SD} = 40 A; T _j = 150 °C		-	5.1	-	V
Dynamic	characteristics				-		
t _{rr}	reverse recovery time	I_{SD} = 40 A; V_{GS} = -4 V; di/dt = 8500 A/µs;		-	15	-	ns
Q _r	recovered charge	V _R = 600 V; T _j = 25 °C		-	530	-	nC
I _{rrm}	reverse recovery current			-	56	-	А
E _{rec}	reverse recovery energy			-	292	-	μJ
t _{rr}	reverse recovery time	I_{SD} = 40 A; V_{GS} = -4 V; di/dt = 10500 A/µs;		-	18	-	ns
Q _r	recovered charge	V _R = 600 V; T _j = 150 °C		-	1000	-	nC
I _{rrm}	reverse recovery current			-	85	-	А
E _{rec}	reverse recovery energy			-	625	-	μJ
NTC the	mistor					1	
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R ₂₅	Rated resistance	T _{NTC} = 25 °C		-	5000	-	Ω
R ₁₀₀		T _{NTC} = 100 °C		465±5%		Ω	
B _{25/50}	B-value	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298.15K))]$			3380		К
	Maximum operating temperature			-	200	-	°C
	Dissipation costant			-	2	-	mW/K
	Thermal time constant			-	≤10	-	s





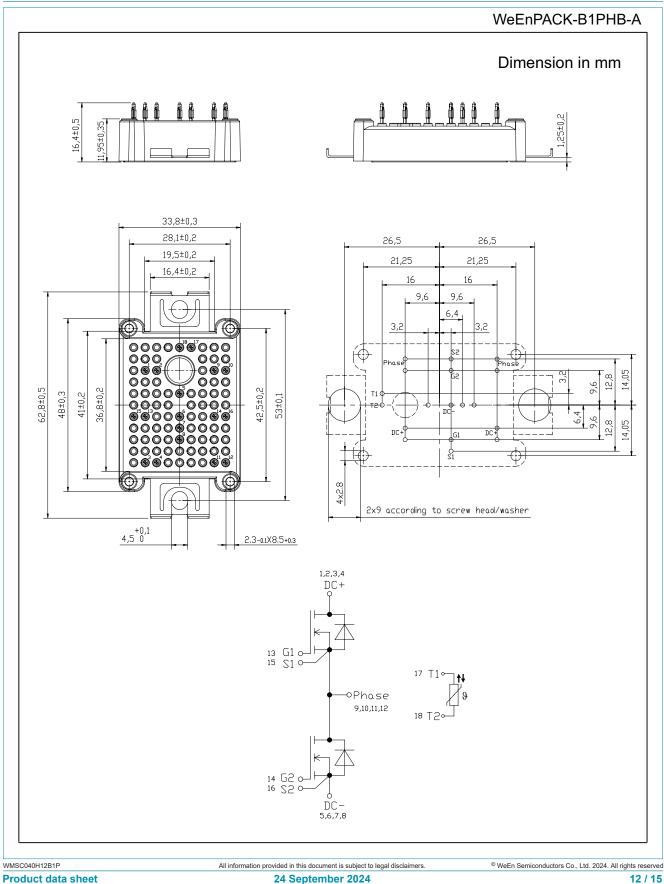






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11. Package outline



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12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

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